

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/772,130	CHEN, JUN	
Examiner		Art Unit		Page 1 of 1
JASON K. LIN		2425		

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-7,254,823	08-2007	Knudson, Edward B	725/46
*	B US-2006/0117348	06-2006	D'Souza et al.	725/040
*	C US-6,792,616	09-2004	Jerding et al.	725/38
*	D US-6,738,982	05-2004	Jerding, Dean F.	725/112
*	E US-2005/0021609	01-2005	Houghton et al.	709/203
*	F US-2007/0033615	02-2007	Hassell et al.	725/046
*	G US-6,305,020	10-2001	Hoarty et al.	725/95
*	H US-6,526,577	02-2003	Knudson et al.	725/40
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.